


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/708,345	YANG ET AL.	
	Examiner	Art Unit	
	Hai H. Huynh	3747	

SEARCHED			
Class	Subclass	Date	Examiner
123	90.11	12/8/2005	HHH
123	90.15	12/8/2005	HHH
123	90.16	12/8/2005	HHH
123	90.17	12/8/2005	HHH
123	568.14	12/8/2005	HHH
123	295	12/8/2005	HHH
123	345-346	12/8/2005	HHH

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East	12/8/2005	HHH